


<b>Search Notes</b> 	<b>Application/Control No.</b> 10823105	<b>Applicant(s)/Patent Under Reexamination</b> KOBAYASHI ET AL.
	<b>Examiner</b> SOPHIE HON	<b>Art Unit</b> 1794

SEARCHED			
Class	Subclass	Date	Examiner
428	1.1, 407, 837, 842.3, 546, 558	12/01/08	SH
349	166	"	"

SEARCH NOTES		
Search Notes	Date	Examiner
EAST 2.2.1 text search attached	12/01/08	SH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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